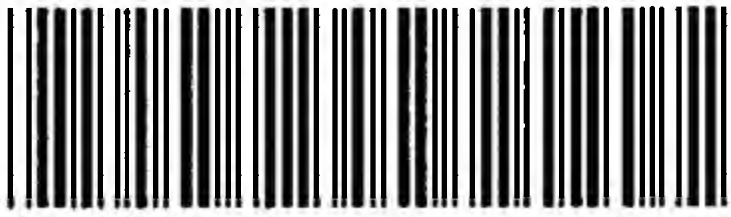


# Search Notes



Application/Control No.

10/710,745

Examiner

Henry K. Choe

Applicant(s)/Patent under  
Reexamination

BONACCIO ET AL.

Art Unit

2817

## SEARCHED

Class	Subclass	Date	Examiner
330	258	11/7/05	H-c.
"	253	"	"
"	259	"	"
"	257	"	"
"	260	11/8/05	"
"	261	"	"

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Tah sul (East) See attachment	11/9/05	H-c.
NPL (IEEE) See attachment	"	"